Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/622,567	JOSEPH, J. MICHAEL
Examiner	Art Unit

3752

Christopher S. Kim

SEARCHED					
Class	Subclass	Date	Examiner		
239	533.12 601	6/21/2007	СК		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	Γ				

(INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
		-		
		<u> </u>		